

Notice of References Cited	Application/Control No. 10/751,562		Applicant(s)/Patent Under Reexamination LEE ET AL.	
	Examiner CHIA-WEI A. CHEN		Art Unit 2622	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,348,681	02-2002	Kindt et al.	250/208.1
*	B	US-6,040,570	03-2000	Levine et al.	250/208.1
*	C	US-6,441,852	08-2002	Levine et al.	348/302
*	D	US-2003/0174226	09-2003	Ahn et al.	348/294
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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